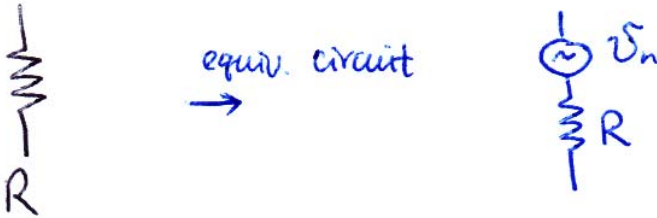


Lecture 40

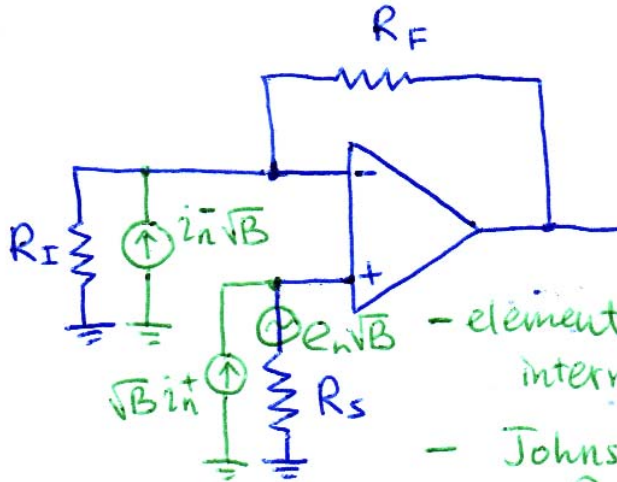
- 1) Horowitz, Hill Ch 7, 15 - great resource on noise
- 2) start with ways to minimize intrinsic noise (prev. lecture)

Noise in op-amps

Recall Johnson noise



$$(\mathcal{V}_n)_{\text{rms}} = \sqrt{4k_B T R B}$$



general configuration

Q: volt. source?

A: omit, superposition; interested only in noise

- elements in green: internal to op-amp

- Johnson volt. noise not shown R_I, R_S, R_F

Noise terms:

- 3 resistors (thermal)
- 2 input current noise sources; see spec. sheets specified as $A/\sqrt{\text{Hz}}$ (i_n^- or i_n^+)
- 1 input voltage noise source; specified as $V/\sqrt{\text{Hz}}$ (e_n)

uncorrelated; total = $\sqrt{\text{term}^2 + \text{term}^2 + \dots}$

$$R_I: \mathcal{V}_{\text{out}}|_{R_I} = \sqrt{4k_B T R_I B} \left(\frac{R_F}{R_I} \right) \leftarrow \text{inverting gain}$$

$$R_F : v_{out} |_{R_F} = \sqrt{4k_B T R_F B}$$

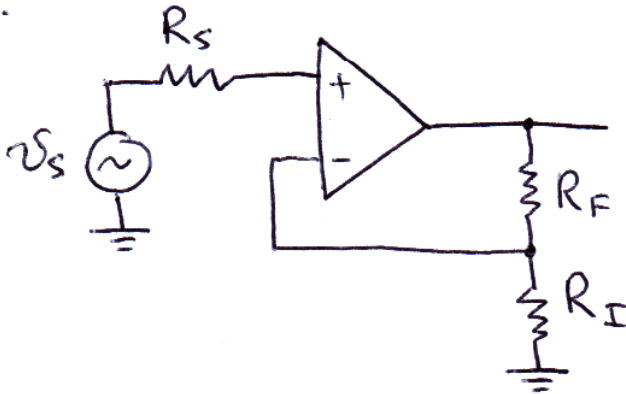
$$R_S : v_{out} |_{R_S} = \sqrt{4k_B T R_S B} \left(1 + \frac{R_F}{R_I}\right) \leftarrow \text{non-inverting gain}$$

$$e_n : v_{out} |_{e_n} = e_n \sqrt{B} \left(1 + \frac{R_F}{R_I}\right)$$

$$i_n^- : v_{out} |_{i_n^-} = i_n^- \sqrt{B} R_F \leftarrow \text{ask the class to show}$$

$$i_n^+ : v_{out} |_{i_n^+} = i_n^+ \sqrt{B} R_S \left(1 + \frac{R_F}{R_I}\right)$$

EX.



E.g. LF356

~100kHz

$e_n \sim 12 \text{ nV}/\sqrt{\text{Hz}}$ (above corner)

$i_n^\pm \sim 0.01 \text{ pA}/\sqrt{\text{Hz}}$

$R_I \approx 1 \text{ k}\Omega$

$R_F = 100 \text{ k}\Omega$

$R_S \approx 5 \text{ k}\Omega$

$B \sim 20 \text{ kHz}$, $T \sim 300 \text{ K}$

$$v_{out} |_{R_I} = 57.6 \text{ }\mu\text{Vrms} \Rightarrow v_{out,n} = 223 \text{ }\mu\text{Vrms}$$

$$v_{out} |_{R_F} = 5.8 \text{ }\mu\text{Vrms}$$

Q: Will TDS1002 scope be able to measure this?

$$v_{out} |_{R_S} = 130 \text{ }\mu\text{Vrms}$$

A: ($1 \text{ M}\Omega$), $60 \text{ MHz BW} \Rightarrow 2 \text{ mV/div}$
only if physical resistor

$$v_{out} |_{e_n} = 171 \text{ }\mu\text{Vrms}$$

$$(v_n)_{rms} \sim 570 \text{ }\mu\text{Vrms}$$

20MHz

$$v_{out} |_{i_n^\pm} < 1 \text{ }\mu\text{Vrms}$$

$$128 \text{ avg} \rightarrow 570 / \sqrt{128} \rightarrow 50 \text{ }\mu\text{Vrms}$$

Yes.

II Interference (often more important than intrinsic) ③

- noise due to sources external to the circuit (or cross-talk)
- can be ~ eliminated

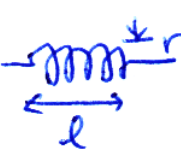
Sources

- any device with spark gap
 - car ignition
 - elect. motors
 - relays
 - fluorescent lights
 - lightning
- power lines / transformers (60Hz)
- radio, TV, wireless
- solar flares
- vibrations

Coupling mechanisms

① Mechanical (microphonics)

- $C \sim \frac{A}{d}$  , d changes $\Rightarrow C$ changes

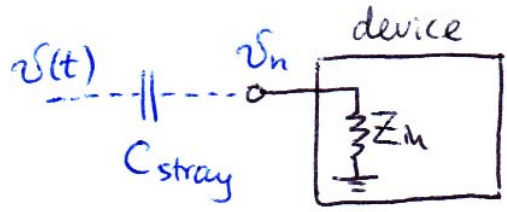
- $L \sim \frac{r^2 (N^2)}{l}$  r, l $\Rightarrow L$

- piezoelectric effect
- flexing coax \rightarrow impedance change, intermittent contact in braid

② Capacitive coupling

- any two conductors connected by E-field lines have capacitance b/w them

- stray C couples volt. fluctuations from other / ext. parts of circuit
- e.g. $C_{stray} \sim 10-100 \frac{pF}{m}$ for a wire run around the lab, couples to $\sim 10-100 V$ due to power lines, fluorescent lights,...

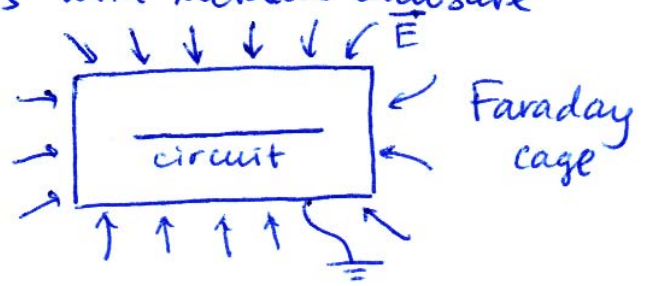


$$v_n \sim v(t) \frac{Z_{in}}{Z_{in} + \frac{1}{j\omega C_s}}$$

E.g. let $R_{in} \sim 1 M\Omega$, $C_s \sim 20 pF$, $v \sim 120 VAC$
 $|Z_{cs}| \sim 133 M\Omega, \Rightarrow v_n \sim 0.9 VAC$

To reduce

- shield all leads & components with metallic enclosure at fixed potential



- use coax or triax (doubly shielded)

- move high level signal parts from high-Z inputs

- run wires close to conducting ground plates to reduce fringing E-fields

